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Kind regards,

Team Nexperia



# PBSS301PD

# 20 V, 4 A PNP low V<sub>CEsat</sub> (BISS) transistor Rev. 03 — 17 December 2007

**Product data sheet** 

### **Product profile**

#### 1.1 General description

PNP low V<sub>CEsat</sub> Breakthrough In Small Signal (BISS) transistor in a SOT457 (SC-74) Surface-Mounted Device (SMD) plastic package.

NPN complement: PBSS301ND.

#### 1.2 Features

- Very low collector-emitter saturation resistance
- Ultra low collector-emitter saturation voltage
- 4 A continuous collector current
- Up to 15 A peak current
- High efficiency due to less heat generation

#### 1.3 Applications

- Power management functions
- Charging circuits
- DC-to-DC conversion
- MOSFET gate driving
- Power switches (e.g. motors, fans)
- Thin Film Transistor (TFT) backlight inverter

#### 1.4 Quick reference data

Table 1. Quick reference data

Symbol	Parameter	Conditions	Min	Тур	Max	Unit
$V_{CEO}$	collector-emitter voltage	open base	-	-	-20	V
I <sub>C</sub>	collector current		<u>[1]</u> _	-	-4	Α
I <sub>CM</sub>	peak collector current	single pulse; $t_p \le 1 \text{ ms}$	-	-	-15	Α
R <sub>CEsat</sub>	collector-emitter saturation resistance	$I_C = -4 \text{ A};$ $I_B = -400 \text{ mA}$	[2] _	50	70	mΩ

<sup>[1]</sup> Device mounted on a ceramic Printed-Circuit Board (PCB), Al<sub>2</sub>O<sub>3</sub>, standard footprint.



<sup>[2]</sup> Pulse test:  $t_p \le 300 \ \mu s; \ \delta \le 0.02.$ 

# 2. Pinning information

Table 2. Pinning

	3		
Pin	Description	Simplified outline	Symbol
1	collector	D- D- D-	
2	collector	<u> </u>	1, 2, 5, 6
3	base	0	3 —
4	emitter	1 12 13	Ì
5	collector		4 sym030
6	collector		5,

# 3. Ordering information

Table 3. Ordering information

Type number	Package	Package				
	Name	Description	Version			
PBSS301PD	SC-74	plastic surface-mounted package (TSOP6); 6 leads	SOT457			

### 4. Marking

Table 4. Marking codes

Type number	Marking code
PBSS301PD	C8

# 5. Limiting values

Table 5. Limiting values

In accordance with the Absolute Maximum Rating System (IEC 60134).

		• • •	•		
Symbol	Parameter	Conditions	Min	Max	Unit
$V_{CBO}$	collector-base voltage	open emitter	-	-20	V
$V_{CEO}$	collector-emitter voltage	open base	-	-20	V
$V_{EBO}$	emitter-base voltage	open collector	-	<b>-</b> 5	V
I <sub>C</sub>	collector current		<u>[1]</u> _	-4	А
I <sub>CM</sub>	peak collector current	single pulse; $t_p \le 1 \text{ ms}$	-	-15	Α
$I_{B}$	base current		-	-0.8	Α
I <sub>BM</sub>	peak base current	single pulse; $t_p \le 1 \text{ ms}$	-	-2	Α
P <sub>tot</sub>	total power dissipation	$T_{amb} \le 25  ^{\circ}C$	[2] _	360	mW
			[3] _	600	mW
			<u>[4]</u> _	750	mW
			<u>[1]</u> -	1.1	W
			[2][5]	2.5	W

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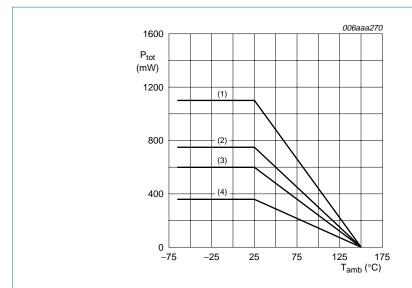
### 20 V, 4 A PNP low V<sub>CEsat</sub> (BISS) transistor

Limiting values ...continued Table 5.

In accordance with the Absolute Maximum Rating System (IEC 60134).

Symbol	Parameter	Conditions	Min	Max	Unit
T <sub>j</sub>	junction temperature		-	150	°C
T <sub>amb</sub>	ambient temperature		-65	+150	°C
T <sub>stg</sub>	storage temperature		-65	+150	°C

- [1] Device mounted on a ceramic PCB, Al<sub>2</sub>O<sub>3</sub>, standard footprint.
- [2] Device mounted on an FR4 PCB, single-sided copper, tin-plated and standard footprint.
- Device mounted on an FR4 PCB, single-sided copper, tin-plated, mounting pad for collector 1 cm<sup>2</sup>. [3]
- [4] Device mounted on an FR4 PCB, single-sided copper, tin-plated, mounting pad for collector 6 cm<sup>2</sup>.
- Operated under pulsed conditions: Duty cycle  $\delta \le 10$  % and pulse width  $t_p \le 10$  ms.



- (1) Ceramic PCB, Al<sub>2</sub>O<sub>3</sub>, standard footprint
- (2) FR4 PCB, mounting pad for collector 6 cm<sup>2</sup>
- (3) FR4 PCB, mounting pad for collector 1 cm<sup>2</sup>
- (4) FR4 PCB, standard footprint

Fig 1. Power derating curves

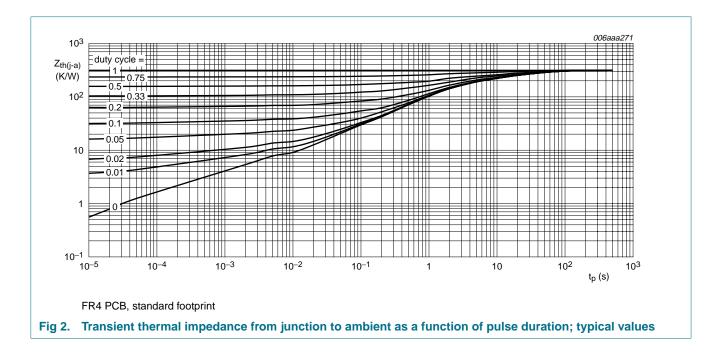
20 V, 4 A PNP low V<sub>CEsat</sub> (BISS) transistor

#### Thermal characteristics 6.

Table 6. Thermal characteristics

Symbol	Parameter	Conditions	Min	Тур	Max	Unit
R <sub>th(j-a)</sub> thermal resistance from junction to ambient	thermal resistance from	in free air	<u>[1]</u> _	-	350	K/W
	junction to ambient		[2] _	-	208	K/W
			[3]	-	167	K/W
			<u>[4]</u> _	-	113	K/W
			[1][5]	-	50	K/W
R <sub>th(j-sp)</sub>	thermal resistance from junction to solder point		-	-	45	K/W

- [1] Device mounted on an FR4 PCB, single-sided copper, tin-plated and standard footprint.
- Device mounted on an FR4 PCB, single-sided copper, tin-plated, mounting pad for collector 1 cm<sup>2</sup>.
- Device mounted on an FR4 PCB, single-sided copper, tin-plated, mounting pad for collector 6 cm<sup>2</sup>.
- Device mounted on a ceramic PCB, Al<sub>2</sub>O<sub>3</sub>, standard footprint.
- Operated under pulsed conditions: Duty cycle  $\delta \! \leq \! 10$  % and pulse width  $t_p \! \leq \! 10$  ms.



20 V, 4 A PNP low V<sub>CEsat</sub> (BISS) transistor

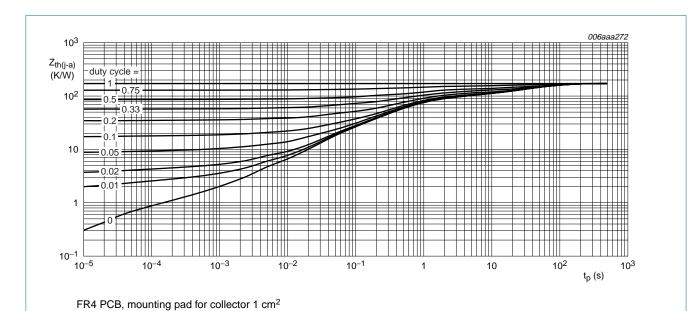


Fig 3. Transient thermal impedance from junction to ambient as a function of pulse duration; typical values

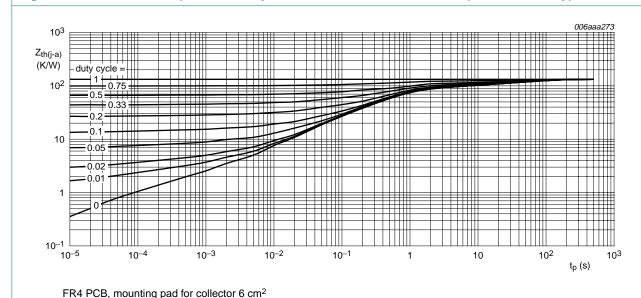


Fig 4. Transient thermal impedance from junction to ambient as a function of pulse duration; typical values

20 V, 4 A PNP low V<sub>CEsat</sub> (BISS) transistor

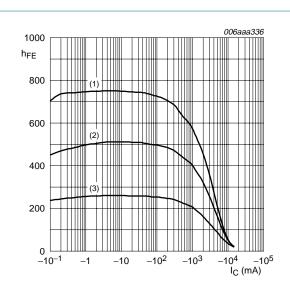
#### **7**. **Characteristics**

Table 7. **Characteristics** 

 $T_{amb} = 25 \,^{\circ}C$  unless otherwise specified.

Symbol	Parameter	Conditions	N	<b>/</b> lin	Тур	Max	Unit
I <sub>CBO</sub>	collector-base cut-off	$V_{CB} = -20 \text{ V}; I_E = 0 \text{ A}$	-		-	-0.1	μΑ
	current	$V_{CB} = -20 \text{ V}; I_E = 0 \text{ A};$ $T_j = 150 ^{\circ}\text{C}$	-		-	-50	μΑ
I <sub>CES</sub>	collector-emitter cut-off current	$V_{CE} = -20 \text{ V}; V_{BE} = 0 \text{ V}$	-		-	-0.1	μΑ
I <sub>EBO</sub>	emitter-base cut-off current	$V_{EB} = -5 \text{ V}; I_C = 0 \text{ A}$	-		-	-0.1	μΑ
h <sub>FE</sub>	DC current gain	$V_{CE} = -2 \text{ V}; I_{C} = -0.5 \text{ A}$	2	250	400	-	
		$V_{CE} = -2 \text{ V}; I_{C} = -1 \text{ A}$	[1] 2	250	400	-	
		$V_{CE} = -2 \text{ V}; I_{C} = -2 \text{ A}$	[1] 2	200	330	-	
		$V_{CE} = -2 \text{ V}; I_{C} = -4 \text{ A}$	[1] 1	20	200	-	
		$V_{CE} = -2 \text{ V}; I_{C} = -6 \text{ A}$	<u>[1]</u> 8	30	130	-	
V <sub>CEsat</sub>	collector-emitter	$I_C = -0.5 \text{ A}; I_B = -50 \text{ mA}$	-		-35	-50	mV
	saturation voltage	$I_C = -1 A$ ; $I_B = -50 \text{ mA}$	-		-65	-90	mV
		$I_C = -2 \text{ A}; I_B = -200 \text{ mA}$	-		-110	-150	mV
		$I_C = -4 \text{ A}; I_B = -400 \text{ mA}$	<u>[1]</u> _		-200	-280	mV
		$I_C = -6 \text{ A}; I_B = -600 \text{ mA}$	<u>[1]</u> -		-300	-420	mV
R <sub>CEsat</sub>	collector-emitter saturation resistance	$I_C = -4 \text{ A}; I_B = -400 \text{ mA}$	<u>[1]</u> -		50	70	$m\Omega$
$V_{BEsat}$	base-emitter	$I_C = -0.5 \text{ A}; I_B = -50 \text{ mA}$	-		-0.8	-0.85	V
	saturation voltage	$I_C = -1 A$ ; $I_B = -50 \text{ mA}$	-		-0.84	-0.9	V
		$I_C = -1 A$ ; $I_B = -100 \text{ mA}$	<u>[1]</u> -		-0.84	-1	V
		$I_C = -4 \text{ A}; I_B = -400 \text{ mA}$	<u>[1]</u> -		-1.0	-1.1	V
$V_{BEon}$	base-emitter turn-on voltage	$V_{CE} = -2 \text{ V}; I_{C} = -2 \text{ A}$	-		-0.8	<b>–1</b>	V
t <sub>d</sub>	delay time	$V_{CC} = -12.5 \text{ V}; I_C = -3 \text{ A};$	-		10	-	ns
t <sub>r</sub>	rise time	$I_{Bon} = -0.15 \text{ A};$	-		35	-	ns
t <sub>on</sub>	turn-on time	$I_{Boff} = 0.15 A$	-		45	-	ns
ts	storage time		-		200	-	ns
t <sub>f</sub>	fall time		-		80	-	ns
t <sub>off</sub>	turn-off time		-		280	-	ns
f <sub>T</sub>	transition frequency	$V_{CE} = -10 \text{ V}; I_{C} = -0.1 \text{ A};$ f = 100 MHz	-		80	-	MHz
C <sub>c</sub>	collector capacitance	$V_{CB} = -10 \text{ V}; I_E = i_e = 0 \text{ A};$ f = 1 MHz	-		80	-	pF

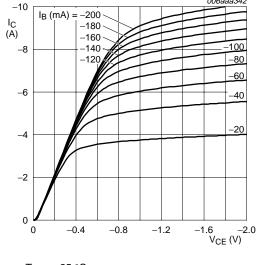
<sup>[1]</sup> Pulse test:  $t_p \le 300 \ \mu s$ ;  $\delta \le 0.02$ .



$$V_{CE} = -2 V$$

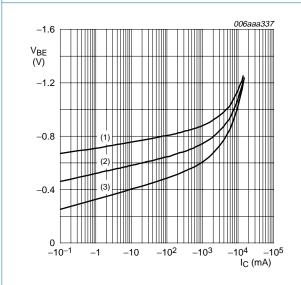
- (1)  $T_{amb} = 100 \, ^{\circ}C$
- (2)  $T_{amb} = 25 \, ^{\circ}C$
- (3)  $T_{amb} = -55 \,^{\circ}C$

Fig 5. DC current gain as a function of collector current; typical values



 $T_{amb} = 25$  °C

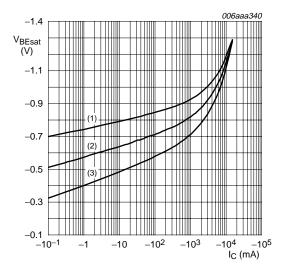
Fig 6. Collector current as a function of collector-emitter voltage; typical values





- (1)  $T_{amb} = -55 \, ^{\circ}C$
- (2) T<sub>amb</sub> = 25 °C
- (3)  $T_{amb} = 100 \, ^{\circ}C$

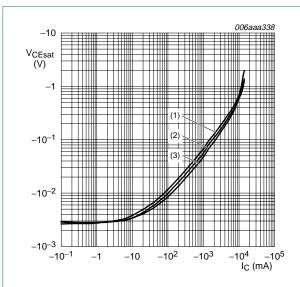
Fig 7. Base-emitter voltage as a function of collector current; typical values



$$I_{\rm C}/I_{\rm B} = 20$$

- (1)  $T_{amb} = -55$  °C
- (2)  $T_{amb} = 25 \, ^{\circ}C$
- (3)  $T_{amb} = 100 \, ^{\circ}C$

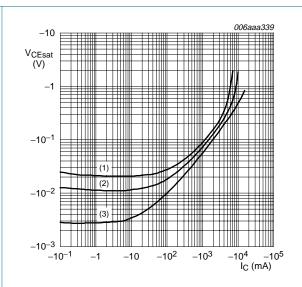
Fig 8. Base-emitter saturation voltage as a function of collector current; typical values



 $I_{\rm C}/I_{\rm B} = 20$ 

- (1)  $T_{amb} = 100 \, ^{\circ}C$
- (2)  $T_{amb} = 25 \, ^{\circ}C$
- (3)  $T_{amb} = -55 \, ^{\circ}C$

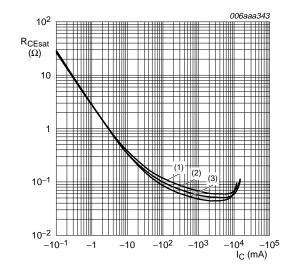
Fig 9. Collector-emitter saturation voltage as a function of collector current; typical values



$$T_{amb} = 25 \, ^{\circ}C$$

- (1)  $I_C/I_B = 100$
- (2)  $I_C/I_B = 50$
- (3)  $I_C/I_B = 10$

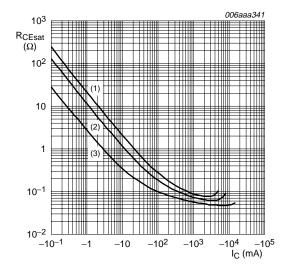
Fig 10. Collector-emitter saturation voltage as a function of collector current; typical values



 $I_{\rm C}/I_{\rm B}=20$ 

- (1)  $T_{amb} = 100 \, ^{\circ}C$
- (2)  $T_{amb} = 25 \, ^{\circ}C$
- (3)  $T_{amb} = -55 \,^{\circ}C$

Fig 11. Collector-emitter saturation resistance as a function of collector current; typical values



T<sub>amb</sub> = 25 °C

- (1)  $I_C/I_B = 100$
- (2)  $I_C/I_B = 50$
- (3)  $I_C/I_B = 10$

Fig 12. Collector-emitter saturation resistance as a function of collector current; typical values

8 of 14

### **Test information**

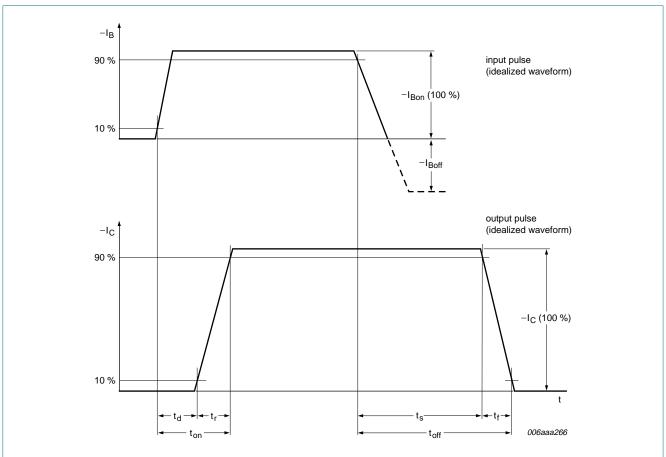
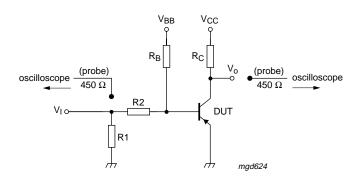


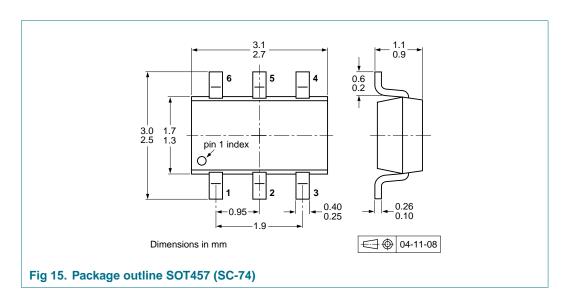
Fig 13. BISS transistor switching time definition



 $V_{CC}$  = -12.5 V;  $I_{C}$  = -3 A;  $I_{Bon}$  = -0.15 A;  $I_{Boff}$  = 0.15 A

Fig 14. Test circuit for switching times

# 9. Package outline



# 10. Packing information

Table 8. Packing methods

The indicated -xxx are the last three digits of the 12NC ordering code.[1]

Type number	Package	Description Pa		quantity
			3000	10000
PBSS301PD	SOT457	4 mm pitch, 8 mm tape and reel; T1	-115	-135
		4 mm pitch, 8 mm tape and reel; T2	-125	-165

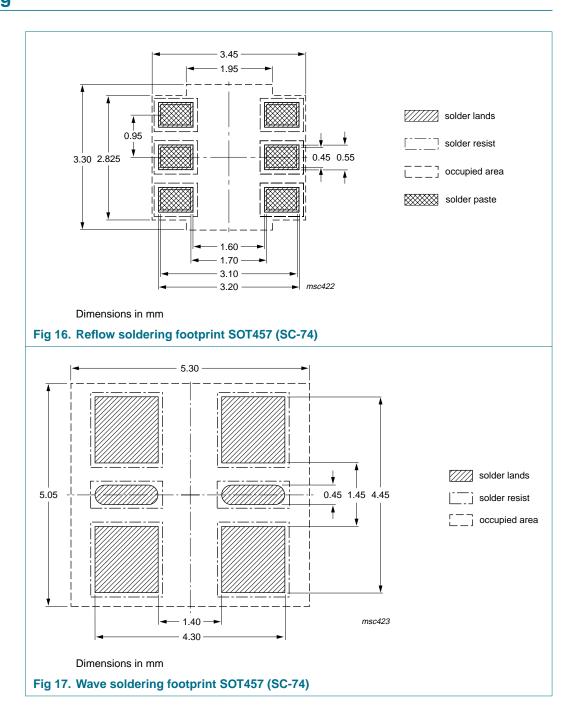
[1] For further information and the availability of packing methods, see  $\underline{\text{Section 14}}$ .

[2] T1: normal taping

[3] T2: reverse taping

20 V, 4 A PNP low V<sub>CEsat</sub> (BISS) transistor

# 11. Soldering



# 12. Revision history

#### Table 9. Revision history

Release date	Data sheet status	Change notice	Supersedes
20071217	Product data sheet	-	PBSS301PD_2
		edesigned to comply w	vith the new identity
<ul> <li>Legal texts h</li> </ul>	ave been adapted to the nev	w company name whe	re appropriate.
<ul> <li>Section 1.1 "</li> </ul>	General description": amend	ded	
<ul> <li><u>Table 6</u>: typing error for maximum value on 6 cm<sup>2</sup> footprint amended</li> </ul>			
• Figure 2, 3, 4, 6, 7 and 11: amended			
• <u>Figure 15</u> : su	uperseded by minimized pac	kage outline drawing	
<ul> <li>Section 11 "S</li> </ul>	Soldering": added		
<ul> <li>Section 13 "L</li> </ul>	<u>egal information"</u> : updated		
20050425	Product data sheet	-	PBSS301PD_1
20050404	Product data sheet	-	-
	The format of guidelines of Legal texts h Section 1.1 Table 6: typin Figure 2, 3, 4 Figure 15: su Section 11 Section 13 Table 120050425	<ul> <li>The format of this data sheet has been reguidelines of NXP Semiconductors.</li> <li>Legal texts have been adapted to the new Section 1.1 "General description": amende</li> <li>Table 6: typing error for maximum value of Figure 2, 3, 4, 6, 7 and 11: amended</li> <li>Figure 15: superseded by minimized pace</li> <li>Section 11 "Soldering": added</li> <li>Section 13 "Legal information": updated</li> <li>Product data sheet</li> </ul>	<ul> <li>Product data sheet -</li> <li>The format of this data sheet has been redesigned to comply we guidelines of NXP Semiconductors.</li> <li>Legal texts have been adapted to the new company name where section 1.1 "General description": amended</li> <li>Table 6: typing error for maximum value on 6 cm² footprint ame Figure 2, 3, 4, 6, 7 and 11: amended</li> <li>Figure 15: superseded by minimized package outline drawing</li> <li>Section 11 "Soldering": added</li> <li>Section 13 "Legal information": updated</li> </ul>

### 13. Legal information

#### 13.1 **Data sheet status**

Document status[1][2]	Product status[3]	Definition
Objective [short] data sheet	Development	This document contains data from the objective specification for product development.
Preliminary [short] data sheet	Qualification	This document contains data from the preliminary specification.
Product [short] data sheet	Production	This document contains the product specification.

- Please consult the most recently issued document before initiating or completing a design.
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Product data sheet

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13 of 14

# PBSS301PD

### 20 V, 4 A PNP low V<sub>CEsat</sub> (BISS) transistor

### 15. Contents

1	Product profile
1.1	General description
1.2	Features
1.3	Applications
1.4	Quick reference data
2	Pinning information
3	Ordering information
4	Marking 2
5	Limiting values
6	Thermal characteristics 4
7	Characteristics
8	Test information
9	Package outline
10	Packing information
11	Soldering
12	Revision history
13	Legal information
13.1	Data sheet status
13.2	Definitions
13.3	Disclaimers
13.4	Trademarks
14	Contact information
15	Contents

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Date of release: 17 December 2007 Document identifier: PBSS301PD\_3

